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FDS6673BZ

P-Channel PowerTrench® MOSFET

-30V, -14.5A, 7.8mΩ

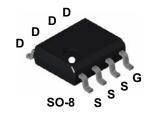
General Description

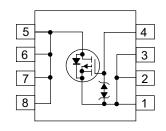
This P-Channel MOSFET is produced using ON Semiconductor's advanced Power Trench process that has been especially tailored to minimize the on-state resistance.

This device is well suited for Power Management and load switching applications common in Notebook Computers and Portable Battery Packs.

Features

- $Max r_{DS(on)} = 7.8 m\Omega, V_{GS} = -10 V, I_D = -14.5 A$
- Max $r_{DS(on)} = 12m\Omega$, $V_{GS} = -4.5V$, $I_D = -12A$
- Extended V_{GS} range (-25V) for battery applications
- HBM ESD protection level of 6.5kV typical (note 3)
- High performance trench technology for extremely low r_{DS(on)}
- High power and current handling capability
- RoHS compliant





MOSFET Maximum Ratings T_A = 25°C unless otherwise noted

| Symbol | Parameter | Ratings | Units |
|-----------------------------------|---|------------|-------|
| V_{DS} | Drain to Source Voltage | -30 | V |
| V_{GS} | Gate to Source Voltage | ±25 | V |
| | Drain Current -Continuous (Note1a) | -14.5 | Α |
| ID | -Pulsed | -75 | Α |
| | Power Dissipation for Single Operation (Note1a) | 2.5 | |
| P_{D} | (Note1b) | 1.2 | W |
| | (Note1c) | 1.0 | |
| T _J , T _{STG} | Operating and Storage Temperature | -55 to 150 | °C |

Thermal Characteristics

| $R_{\theta JA}$ | Thermal Resistance , Junction to Ambient (Note 1a) | 50 | °C/W |
|-----------------|--|----|------|
| $R_{\theta JC}$ | Thermal Resistance , Junction to Case (Note 1) | 25 | °C/W |

Package Marking and Ordering Information

| Device Marking | Device | Reel Size | Tape Width | Quantity |
|----------------|-----------|-----------|------------|------------|
| FDS6673BZ | FDS6673BZ | 13" | 12mm | 2500 units |

Electrical Characteristics T_J = 25°C unless otherwise noted

| Symbol | Parameter | Test Conditions | Min | Тур | Max | Units | | |
|--|--|--|-----|-----|-----|-------|--|--|
| Off Characteristics | | | | | | | | |
| B _{VDSS} | Drain to Source Breakdown Voltage | $I_D = -250 \mu A, V_{GS} = 0 V$ | -30 | | | V | | |
| $\frac{\Delta B_{VDSS}}{\Delta T_{J}}$ | Breakdown Voltage Temperature Coefficient | I_D = -250 μ A, referenced to 25°C | | -20 | | mV/°C | | |
| I _{DSS} | Zero Gate Voltage Drain Current | V _{DS} = -24V, V _{GS} = 0V | | | -1 | μΑ | | |
| I _{GSS} | Gate to Source Leakage Current | $V_{GS} = \pm 25V, V_{DS} = 0V$ | | | ±10 | μΑ | | |

On Characteristics (Note 2)

| $V_{GS(th)}$ | Gate to Source Threshold Voltage | $V_{GS} = V_{DS}, I_{D} = -250 \mu A$ | -1 | -1.9 | -3 | V |
|--|--|---|----|------|-----|--------------|
| $\frac{\Delta V_{GS(th)}}{\Delta T_J}$ | Gate to Source Threshold Voltage Temperature Coefficient | I_D = -250 μ A, referenced to 25°C | | 8.1 | | mV/°C |
| r _{DS(on)} | Drain to Source On Resistance | $V_{GS} = -10V$, $I_D = -14.5A$ | | 6.5 | 7.8 | |
| | | $V_{GS} = -4.5V, I_D = -12A$ | | 9.6 | 12 | m_{Ω} |
| | | $V_{GS} = -10V, I_D = -14.5A$ $T_J = 125^{\circ}C$ | | 9.7 | 12 | 11132 |
| 9 _{FS} | Forward Transconductance | $V_{DS} = -5V, I_{D} = -14.5A$ | | 60 | | S |

Dynamic Characteristics

| C _{iss} | Input Capacitance | V _{DS} = -15V, V _{GS} = 0V, f = 1.0MHz | 3500 | 4700 | pF |
|------------------|------------------------------|---|------|------|----|
| C _{oss} | Output Capacitance | | 600 | 800 | pF |
| C _{rss} | Reverse Transfer Capacitance | 1 = 1.000112 | 600 | 900 | pF |

Switching Characteristics (Note 2)

| t _{d(on)} | Turn-On Delay Time | | 14 | 26 | ns |
|---------------------|----------------------------|---|------|-----|----|
| t _r | Rise Time | $V_{DD} = -15V, I_{D} = -1A$ $V_{GS} = -10V, R_{GS} = 6\Omega$ | 16 | 29 | ns |
| t _{d(off)} | Turn-Off Delay Time | $V_{GS} = -10V, H_{GS} = 602$ | 225 | 36 | ns |
| t _f | Fall Time | | 105 | 167 | ns |
| Qg | Total Gate Charge | $V_{DS} = -15V, V_{GS} = -10V,$ $I_{D} = -14.5A$ | 88 | 124 | nC |
| Q _g | Total Gate Charge | 151/1/ 51/ | 46 | 65 | nC |
| Q_{gs} | Gate to Source Gate Charge | $V_{DS} = -15V, V_{GS} = -5V,$ $I_{D} = -14.5A$ | 8 | | nC |
| Q_{gd} | Gate to Drain Charge | 1D = -14.5A | 23.5 | | nC |

Drain-Source Diode Characteristics

| V _{SD} | Source to Drain Diode Forward Voltage | $V_{GS} = 0V, I_S = -2.1A$ | -0.7 | -1.2 | V |
|-----------------|---------------------------------------|--------------------------------------|------|------|----|
| t _{rr} | Reverse Recovery Time | $I_F = 14.5A$, $di/dt = 100A/\mu s$ | | 45 | ns |
| Q _{rr} | Reverse Recovery Charge | $I_F = 14.5A$, $di/dt = 100A/\mu s$ | | 34 | nC |

1: R_{0JA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{0JC} is guaranteed by design while R_{0CA} is determined by the user's board design.



a) 50 °C/W (10 sec) when mounted on a 1 in² pad of 2 oz copper





Scale 1:1 on letter size paper

- 2: Pulse Test: Pulse Width < 300 µs, Duty Cycle < 2.0%.
- 3: The diode connected between the gate and source serves only as protection against ESD. No gate overvoltage rating is implied.

Typical Characteristics T_J = 25°C unless otherwise noted

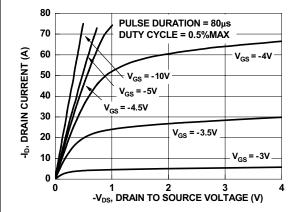


Figure 1. On Region Characteristics

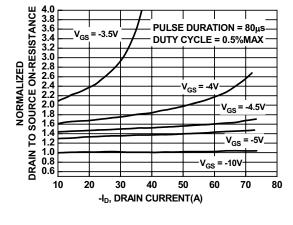


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

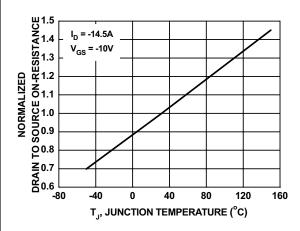


Figure 3. Normalized On Resistance vs Junction Temperature

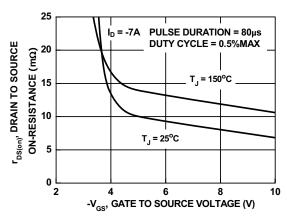


Figure 4. On-Resistance vs Gate to Source Voltage

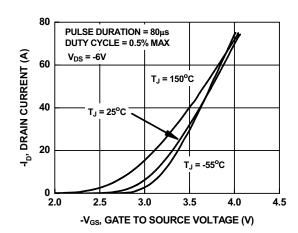


Figure 5. Transfer Characteristics

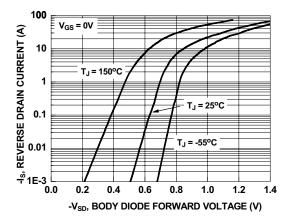
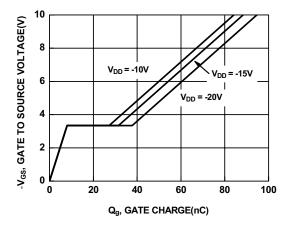


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics $T_J = 25^{\circ}C$ unless otherwise noted



C_{iss}

1000

f = 1MHz
V_{GS} = 0V

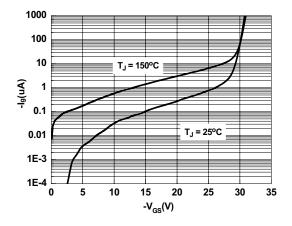
100

-V_{DS}, DRAIN TO SOURCE VOLTAGE (V)

6000

Figure 7. Gate Charge Characteristics

Figure 8. Capacitance vs Drain to Source Voltage



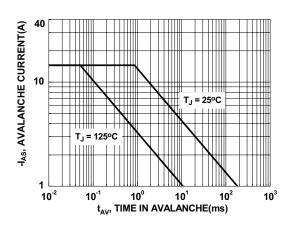
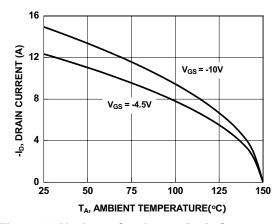


Figure 9. $I_g vs V_{GS}$

Figure 10. Unclamped Inductive Switching Capability



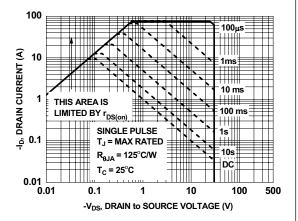


Figure 11. Maximum Continuous Drain Current vs
Ambient Temperature

Figure 12. Forward Bias Safe Operating Area

Typical Characteristics $T_J = 25$ °C unless otherwise noted

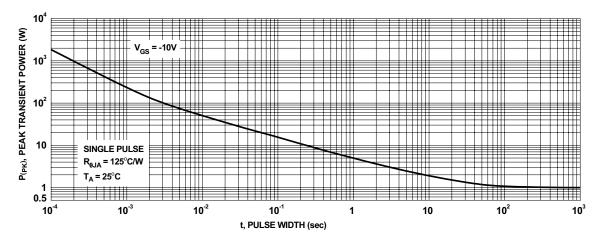


Figure 13. Single Pulse Maximum Power Dissipation

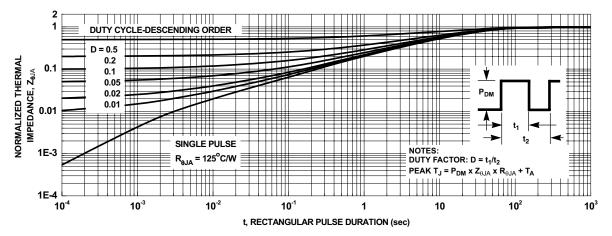


Figure 14. Junction-to-Ambient Transient Thermal Response Curve

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